Hypothesis Testing*

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- 1. basic notions in hypothesis testing
- 1.1 statistical hypothesis
- 2. finding and evaluating tests
- 2.1 likelihood ratio test
- 2.2 most powerful tests
- 2.3 $\,$ restricting the class of UMP test $\,$
- 2.4 intersection-union and union-intersection tests
- 2.5 p-values
- 3. inference and set estimation
- 3.1 inverting a test statistic
- 3.2 evaluating interval estimators and optimality
- 4. exercises

 $1. \ \mbox{basic notions in hypothesis testing}$

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some definitions: null and alternative hypothesis

- definition: a statistical hypothesis is a statement about population parameters
- the goal is to decide which of two complementary hypotheses is true:

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null hypothesis \mathbb{H}_0 vs alternative hypothesis \mathbb{H}_1
```

- if θ denotes a population parameter, then the general format of the null and alternative hypotheses is $\mathbb{H}_0: \theta \in \Theta_0$ and $\mathbb{H}_1: \theta \in \Theta_1$
- examples:
 - if θ represents the effect of a training program, we might be interested in $\mathbb{H}_0: \theta=0$ against $\mathbb{H}_1: \theta\neq 0$
 - if σ^2 is the variance, we might be interested in understanding if volatility is too high defining $\mathbb{H}_0: \sigma^2 = \sigma_0^2$ against $\mathbb{H}_1: \sigma^2 > \sigma_0^2$

some definitions: rejection region

- definition: a hypothesis test is a rule that determines for which sample values the decision is to reject or not \mathbb{H}_0
 - we define a partition in the sample space ${\mathcal X}$ with two sets: R and R^c
 - if $x \in R$, we elect to reject \mathbb{H}_0 ; if $x \in R^c$, we elect to not reject \mathbb{H}_0
 - -R is the rejection region and R^c is the acceptance region
 - typically, a hypothesis test is specified in terms of a test statistic T(x), but this is not necessary
 - R (and, consequently, R^c) can be defined arbitrarily but makes little sense to do so if we want a test with good properties

some definitions: power function

• definition: the power function of a hypothesis test with a given rejection region R is the function of θ

$$eta(oldsymbol{ heta}) \;\;=\;\; \mathbb{P}_{oldsymbol{ heta}}(oldsymbol{X}\in R)$$

- be careful: the power function \neq power of the test!
- the terminology is misleading: one should think the power function as the probability of rejecting the null as a function of θ , regardless of whether the null is true or not

some definitions: type-I and type-II errors

- there are two types of error a hypothesis test $\mathbb{H}_0: \theta \in \Theta_0$ vs $\mathbb{H}_1: \theta \in \Theta_1$ might make
 - rejecting the null when it is true (false positive): type I error occurs if $\theta \in \Theta_0$ and $x \in R$
 - not rejecting the null when it is false (false negative): type II occurs if $\theta \in \Theta_1$ and $x \notin R$

		decision	
		not reject \mathbb{H}_0	reject \mathbb{H}_0
		$x \notin R$	$x \in R$
truth	$\mathbb{H}_{0}: oldsymbol{ heta} \in \Theta_{0}$	correct	type l
	$\mathbb{H}_{1}:oldsymbol{ heta}\in\Theta_{1}$	type II	correct

size and power function

for each θ ∈ Θ₀, β(θ) = ℙ_θ(X ∈ R) represents the probability that the null hypothesis is rejected while being true.

$$\mathsf{if}\; \boldsymbol{\theta}\in \Theta_{0}:\, \beta(\boldsymbol{\theta})\;=\; \mathbb{P}_{\boldsymbol{\theta}}(X\in R)\;=\; \mathbb{P}_{\boldsymbol{\theta}}(\mathsf{type}\;\mathsf{I}\;\mathsf{error})\;=\;\mathsf{size}\;\mathsf{at}\;\boldsymbol{\theta}$$

• size varies with θ : we need an aggregate measure for the entire test over the set Θ_0

- example: suppose X_i ~ N(μ, 1) i.i.d. and that we test H₀ : μ > 0 against H₁ : μ ≤ 0. We elect to make R = {x̄_n ≤ 0}. The probability of x̄_n being in the rejection region is completely different if μ = 0.0001 or μ = 1000.
- definition: for $0 \le \alpha \le 1$, a test with power function $\beta(\theta)$ has size α if

$$\sup_{\boldsymbol{\theta}\in\Theta_{\mathbf{0}}}\beta(\boldsymbol{\theta})=\alpha$$

whereas it has level α if $\sup_{\theta \in \Theta_0} \beta(\theta) \leq \alpha$.

• ideally, we would have size 0, which is equivalent to $\beta(\theta) = 0$ for all $\theta \in \Theta_0$, but life is never this perfect

power and power function

for each θ ∈ Θ₁, β(θ) = P_θ(X ∈ R) represents the probability that the null hypothesis is rejected while being false.

 $\mathsf{if}\; \boldsymbol{\theta} \in \Theta_1: \, \beta(\boldsymbol{\theta}) \; = \; \mathbb{P}_{\boldsymbol{\theta}}(X \in R) \; = \; 1 - \mathbb{P}_{\boldsymbol{\theta}}(\mathsf{type}\; \mathsf{II\; error}) \; = \; \mathsf{power}\; \mathsf{at}\; \boldsymbol{\theta}$

• as with size, power varies with θ , but we choose not to define an aggregate measure over $\theta \in \Theta_1$

power function for binomial probability

- example 1: let $X \sim Bin(5, p)$ and consider testing $\mathbb{H}_0: \Theta_0 = \{p: 0 \le p \le 1/2\}$ vs $\mathbb{H}_1: \Theta_1 = \{p: 1/2$
- test 1: $x \in R$ if and only if every observation is a success
 - $\beta_1(p) = \mathbb{P}_p(X=5) = p^5$
 - probability of type I error is pretty low for any $p \leq 1/2$ $(\frac{1}{2^5} = 0.0312)$
 - probability of type II error is less than half only if $p > 0.5^{1/5} = 0.87$
- test $2 \times \in R$ if and only if $X \in \{3, 4, 5\}$

$$- \beta_2(p) = \mathbb{P}_p(X \in \{3, 4, 5\}) = \sum_{x=3}^5 {5 \choose x} p^x (1-p)^{5-x}$$

- the price we pay for a much smaller probability of type II error is a larger probability of type I error

test 1 : $x \in R$ if and only if every observation is a success test 2 : $x \in R$ if and only if $X \in \{3, 4, 5\}$

```
r1 <- function(p){mean(rbinom(5000,5,p)==5)}
r2 <- function(p){mean(rbinom(5000,5,p)>=3)}
p <- seq(0,1,by=0.01)
plot(p,sapply(p,r1),type='1',ylab='beta(p)',xlab='p')
lines(p,sapply(p,r2),type='1',col='red')</pre>
```



р

```
test 3:rejects \mathbb{H}_0 if and only if X \in \{2, 3, 4, 5\}test 4:rejects \mathbb{H}_0 if and only if X \in \{1, 5\}test 5:rejects \mathbb{H}_0 if and only if X \in \{1, 3, 5\}test 6:rejects \mathbb{H}_0 if and only if X \in \{1, 2\}
```

```
r3 <- function(p){mean(rbinom(5000,5,p)>=2)}
```

```
r4 <- function(p){
    v <- rbinom(5000,5,p)
    mean((v==1)+(v==5))
}
r5 <- function(p){
    v <- rbinom(5000,5,p)
    mean((v==1)+(v==3)+(v==5))
}
r6 <- function(p){mean(rbinom(5000,5,p)<=2)}</pre>
```



• example 2: let $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$ and consider testing $\mathbb{H}_0 : \mu \leq 0$ versus $\mathbb{H}_0 : \mu > 0$. For that test, we propose two rejection regions

test 1 : $x \in R$ if and only if $\bar{X}_n > 0$ test 2 : $x \in R$ if and only if $X_1 > 0$

n <- 50

```
rGaussian1 <- function(mu){
    vecTest <- matrix(0,5000,1)
    for (i in 1:5000){vecTest[i,1] <- mean(rnorm(n,mean=mu,sd=1)) > 0}
    mean(vecTest)
}
rGaussian2 <- function(mu){
    vecTest <- matrix(0,5000,1)
    for (i in 1:5000){vecTest[i,1] <-(rnorm(1,mean=mu,sd=1)) > 0}
    mean(vecTest)
}
```



mu

- example 2 (cont'd): rejection/acceptance region *R* are generally arbitrary; but it is unlikely that tests with good properties would ensue
- let $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$ and consider testing $\mathbb{H}_0 : \mu \leq 100$ versus $\mathbb{H}_0 : \mu > 100$. For that test, keep the two previous tests

test 1 : $x \in R$ if and only if $\bar{X}_n > 0$ test 2 : $x \in R$ if and only if $X_1 > 0$

this test will have massive size distortions, and power very close to 1.

• in the next example, we conveniently standardize the test statistic.

• example 3: let $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$ and consider testing $\mathbb{H}_0: \mu \leq \mu_0$ versus $\mathbb{H}_1: \mu > \mu_0$ using a rejection region $\bar{X}_n > \kappa$.

- we now aim to choose κ such that we know the probability type-I errors, i.e., we aim to devise a test with a defined size
 - in other words, α and n are fixed and we let power roam free

• we know that

$$eta(\mu) = \mathbb{P}_{\mu}\left(\bar{X}_n > \kappa\right)$$

but we can't calculate this probability because μ is not known, so we instead compute

$$eta(\mu) = \mathbb{P}_{\mu}\left(rac{ar{X}_n-\mu}{1/\sqrt{n}}>rac{\kappa-\mu}{1/\sqrt{n}}
ight) = \mathbb{P}\left(Z>rac{\kappa-\mu}{1/\sqrt{n}}
ight)$$

with $Z \sim N(0, 1)$.

• important to notice: we've manipulated $\beta(\mu)$ so that it depends on some known distribution (and not on μ). In this way, we may forgo the simulations

• we may choose κ to match a test size from

$$eta(\mu) \hspace{.1in} = \hspace{.1in} \mathbb{P}\left(Z > rac{\kappa-\mu}{1/\sqrt{n}}
ight)$$

- since $\beta(\mu)$ is increasing with μ , maximum $\beta(\mu) = \mathbb{P}\left(Z > \frac{\kappa \mu}{1/\sqrt{n}}\right)$ subject to $\mathbb{H}_0 : \mu \leq \mu_0$ is achieved at $\mu = \mu_0$
- so we select κ such that

$$\mathbb{P}\left(Z > \frac{\kappa - \mu_0}{1/\sqrt{n}}\right) = \alpha$$

• from the standard normal tables, there is value z_{α} such that $\mathbb{P}(Z > z_{\alpha}) = \alpha$. For example, if $\alpha = 0.05$, $z_{\alpha} \approx 1.64$. Therefore,

$$\frac{\kappa - \mu_0}{1/\sqrt{n}} = z_\alpha \implies \kappa = \mu_0 + \frac{z_\alpha}{\sqrt{n}}$$

• the rejection region

$$R = \left\{ X : \bar{X}_n > \mu_0 + \frac{z_\alpha}{\sqrt{n}} \right\}$$

was defined such that the statistical test has size $\boldsymbol{\alpha}$

• this is not necessarily the most convenient formulation: consider testing $\mathbb{H}_0: \mu \leq \mu_0$ versus $\mathbb{H}_1: \mu > \mu_0$ using a rejection region $\frac{\bar{X}_n - \mu_0}{1/\sqrt{n}} > c$

$$\begin{split} \beta(\mu) &= \mathbb{P}_{\mu}\left(\frac{\bar{X}_{n}-\mu_{0}}{1/\sqrt{n}} > c\right) = \mathbb{P}_{\mu}\left(\frac{\bar{X}_{n}-\mu+\mu-\mu_{0}}{1/\sqrt{n}} > c\right) \\ &= \mathbb{P}_{\mu}\left(\frac{\bar{X}_{n}-\mu}{1/\sqrt{n}} + \frac{\mu-\mu_{0}}{1/\sqrt{n}} > c\right) = \mathbb{P}_{\mu}\left(\frac{\bar{X}_{n}-\mu}{1/\sqrt{n}} > c - \frac{\mu-\mu_{0}}{1/\sqrt{n}}\right) \\ &= \mathbb{P}\left(Z > c + \frac{\mu_{0}-\mu}{1/\sqrt{n}}\right) \text{ with } Z \sim N(0,1) \end{split}$$

- important:
 - $-\ eta(\mu)$ is increasing in μ , with $\lim_{\mu \to -\infty} eta(\mu) = 0$, $\lim_{\mu \to \infty} eta(\mu) = 1$
 - if $\mathbb{P}(Z > c) = \alpha$, then $\beta(\mu_0) = \alpha$, the size of the test
 - to control for size lpha, we choose $c=z_{lpha}$
 - $-\,$ power depends on the distance $\mu_0-\mu$
 - $-\,$ power increases to 1 as $n \to \infty$

• that is, we have defined the rejection region

$$R = \left\{ X : \frac{\bar{X}_n - \mu_0}{1/\sqrt{n}} > z_\alpha \right\} = \left\{ X : \bar{X}_n > \mu_0 + \frac{z_\alpha}{\sqrt{n}} \right\}$$

as we had before.

mu0 <- 1

c <- 1.64485

```
rGaussian2 <- function(mu){
  vecTest <- matrix(0,5000,1)
  for (i in 1:5000){vecTest[i,1] <-
      (sqrt(n)*(mean(rnorm(n,mean=mu,sd=1))-mu0)) > c}
  mean(vecTest)
}
```

c = 1.64485, $\alpha = 0.05$



mu

c = -0.25334, $\alpha = 0.60$



mu

- example 4: suppose now that the probability of type I error must not exceed 0.10 and that of type II error must not exceed 0.20 if $\mu \ge \mu_0 + 1$
- we now aim to choose n such that we know the probability type-I and type-II errors for a given
 effect size
 - typical application: determination of sample sizes in RCTs.
- using a test that rejects $\mathbb{H}_0: \mu \leq \mu_0$ if $\sqrt{n}(\bar{X}_n \mu_0) > c$

$$\beta(\mu) = \mathbb{P}\left(Z > c + \frac{\mu_0 - \mu}{1/\sqrt{n}}\right) = \begin{cases} \mathbb{P}(Z > c) = 0.1 & \text{if } \mu = \mu_0 \\ \mathbb{P}(Z > c - \sqrt{n}) = 0.8 & \text{if } \mu = \mu_0 + 1 \end{cases}$$

• from $\mathbb{P}(Z > c) = 0.1$, we get that c pprox 1.28

• from $\mathbb{P}(Z > c - \sqrt{n}) = 0.8$, we get that

$$c-\sqrt{n} \approx -0.84 \Rightarrow n \approx (c+0.84)^2 \approx 4.49$$

or $n \ge 5$

• example 5: let X_1, \ldots, X_n be a random sample from $N(\theta, \sigma^2)$, σ^2 known. A test for $\mathbb{H}_0 : \theta = \theta_0$ against $\mathbb{H}_1 : \theta \neq \theta_0$ rejects \mathbb{H}_0 if $|\bar{X}_n - \theta_0|/(\sigma/\sqrt{n}) > c$.

the experimenter desires a type-I error of probability 0.05 and a maximum type-II error of 0.25 at $\theta = \theta_0 + \sigma$. What values of *n* and *c* achieves this?

• we should first find the power function

$$\begin{split} \mathcal{B}(\theta) &= \mathbb{P}_{\theta}\left(\frac{|\bar{x}_{n} - \theta_{0}|}{\sigma/\sqrt{n}} > c\right) &= 1 - \mathbb{P}_{\theta}\left(\frac{|\bar{x}_{n} - \theta_{0}|}{\sigma/\sqrt{n}} \le c\right) \\ &= 1 - \mathbb{P}_{\theta}\left(-c \le \frac{\bar{x}_{n} - \theta + \theta - \theta_{0}}{\sigma/\sqrt{n}} \le c\right) \\ &= 1 - \mathbb{P}_{\theta}\left(-c - \frac{\theta - \theta_{0}}{\sigma/\sqrt{n}} \le \frac{\bar{x}_{n} - \theta}{\sigma/\sqrt{n}} \le c - \frac{\theta - \theta_{0}}{\sigma/\sqrt{n}}\right) \\ &= 1 - \mathbb{P}_{\theta}\left(-c + \frac{\theta_{0} - \theta}{\sigma/\sqrt{n}} \le Z \le c + \frac{\theta_{0} - \theta}{\sigma/\sqrt{n}}\right) \\ &= 1 - \left[\Phi\left(c + \frac{\theta_{0} - \theta}{\sigma/\sqrt{n}}\right) - \Phi\left(-c + \frac{\theta_{0} - \theta}{\sigma/\sqrt{n}}\right)\right] \end{split}$$

• by hypothesis,

$$\begin{array}{rcl} 0.05 & = & \beta(\theta_0) & = & 1 - [\Phi(c) - \Phi(-c)] \\ & = & 1 - [\Phi(c) - 1 + \Phi(c)] & = & 2 - 2 \cdot \Phi(c) \\ 0.025 & = & 1 - \Phi(c) \end{array}$$

and c = 1.96.

• power at $\theta = \theta_0 + \sigma$ is

$$\begin{array}{rcl} .75 & \leq & \beta(\theta_0 + \sigma) \ = \ 1 - \left[\Phi\left(c + \frac{-\sigma}{\sigma/\sqrt{n}}\right) - \Phi\left(-c + \frac{-\sigma}{\sigma/\sqrt{n}}\right) \right] \\ & = & 1 + \Phi(-c - \sqrt{n}) - \Phi(c - \sqrt{n}) \\ & = & 1 + \Phi(-1.96 - \sqrt{n}) - \Phi(1.96 - \sqrt{n}) \\ & \approx & 1 - \Phi(1.96 - \sqrt{n}) \end{array}$$

since $\Phi(-.675) \approx 0.25$, then $1.96 - \sqrt{n} = -.675$, and so $n = 6.943 \approx 7$.

• example 6: let X_1, \ldots, X_n be a random sample from $N(\theta, \sigma^2)$, σ^2 unknown. A test for $\mathbb{H}_0 : \theta = \theta_0$ against $\mathbb{H}_1 : \theta \neq \theta_0$ rejects \mathbb{H}_0 if $|\bar{X}_n - \theta_0|/(s/\sqrt{n}) > c$, where $s = \sqrt{s^2} = \sqrt{\frac{1}{n-1}\sum_{i=1}^n (X_i - \bar{X}_n)^2}$.

the experimenter desires a type-I error of probability 0.05 and a maximum type-II error of 0.25 at $\theta = \theta_0 + \sigma$. What values of *n* and *c* achieves this?

• we should adjust the power function

$$egin{aligned} eta(heta) &= & \mathbb{P}_{ heta}\left(rac{|ar{x}_n- heta_0|}{s/\sqrt{n}}>c
ight) &= & 1-\mathbb{P}_{ heta}\left(rac{|ar{x}_n- heta_0|}{s/\sqrt{n}}\leq c
ight) \ &= & 1-\mathbb{P}_{ heta}\left(-c\leq rac{ar{x}_n- heta+ heta- heta_0}{s/\sqrt{n}}\leq c
ight) \ &= & 1-\mathbb{P}_{ heta}\left(-c-rac{ heta- heta_0}{s/\sqrt{n}}\leq rac{ar{x}_n- heta}{s/\sqrt{n}}\leq c-rac{ heta- heta_0}{\sigma/\sqrt{n}}
ight) \ &= & 1-\mathbb{P}_{ heta}\left(-c+rac{ heta_0- heta}{s/\sqrt{n}}\leq t\leq c+rac{ heta_0- heta}{s/\sqrt{n}}
ight) \ &= & 1-\mathbb{P}_{ heta}\left(-c+rac{ heta_0- heta}{s/\sqrt{n}}\leq t\leq c+rac{ heta_0- heta}{s/\sqrt{n}}
ight) \ &= & 1-\mathbb{P}_{ heta}\left(-c+rac{ heta_0- heta}{s/\sqrt{n}}
ight)-\mathcal{F}\left(-c+rac{ heta_0- heta}{s/\sqrt{n}}
ight) \ &= & 1-\left[\mathcal{F}\left(c+rac{ heta_0- heta}{s/\sqrt{n}}
ight)-\mathcal{F}\left(-c+rac{ heta_0- heta}{s/\sqrt{n}}
ight)
ight] \end{array}$$

where $t \sim t_{n-1}$ with cdf $F(\cdot)$.

power function for Bernoulli with CLT

- example 7: for a random sample X₁,..., X_n of Bernoulli(p) variables, it is desired to test
 ^{III} ≡ p = 0.49 against H₁ : p = 0.51. Use the central limit theorem to determine, approximately,
 the sample size needed so that the two probabilities of error are both about 0.01. Use a test
 function that rejects H₀ if ∑_{i=1}ⁿ X_i is large.
- solution: by the CLT,

$$Z = \frac{\sum X_i - np}{\sqrt{np(1-p)}} \stackrel{d}{\longrightarrow} N(0,1)$$

a test that rejects \mathbb{H}_0 if $\sum X_i > c$ has

$$\mathbb{P}\left(Z > rac{c - n(.49)}{\sqrt{n(.49)(.51)}}
ight) = 0.01 ext{ and } \mathbb{P}\left(Z > rac{c - n(.51)}{\sqrt{n(.49)(.51)}}
ight) = 0.01$$

therefore

$$\frac{c - n(.49)}{\sqrt{n(.49)(.51)}} = 2.33 \text{ and } \frac{c - n(.51)}{\sqrt{n(.49)(.51)}} = -2.33$$

solving these equations gives n = 13.567 and c = 6783.5.

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previous examples

• in most previous examples, we've used rejection regions of the format

$$R = \left\{ X : T(X) > \kappa \right\}$$

which is an interval (κ, ∞) for a sufficient statistic T(X).

- example 2:
$$R = \left\{ X : \bar{X}_n > 0 \right\}$$

- example 3: $R = \left\{ X : \bar{X}_n > \frac{z_{\alpha}}{\sqrt{n} + \mu_0} \right\}$
- example 4: $R = \left\{ X : \sqrt{n}(\bar{X}_n - \mu_0) > c \right\}$
- example 5: $R = \left\{ X : |\bar{X}_n - \theta_0| / (\sigma/\sqrt{n}) > c \right\}$
- example 6: $R = \left\{ X : \sum X_i \text{ "large"} \right\}$

• we are going to see that rejection regions of this format are well-grounded by theory

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likelihood ratio test

- it is a very general method of finding acceptance/rejection regions, virtually always applicable and optimal in some sense that we will discuss later
- definition: the LR test for ℍ₀: θ ∈ Θ₀ against ℍ₁: θ ∈ Θ₁ is a test with a rejection region of the form R = {x : λ(x) ≤ c}, where 0 ≤ c ≤ 1 and

$$\lambda(\mathbf{x}) = \frac{\sup_{\boldsymbol{\theta} \in \Theta_{\mathbf{0}}} \ell(\boldsymbol{\theta} | \mathbf{x})}{\sup_{\boldsymbol{\theta} \in \Theta} \ell(\boldsymbol{\theta} | \mathbf{x})} = \frac{\ell(\hat{\boldsymbol{\theta}}_{0} | \mathbf{x})}{\ell(\hat{\boldsymbol{\theta}} | \mathbf{x})}$$

- if the restriction is not binding, the constrained maximization $\ell(\hat{\theta}_0|\mathbf{x})$ will be the same as the unconstrained maximization $\ell(\hat{\theta}|\mathbf{x})$ and $\lambda(\mathbf{x}) = 1$
- for now, think c as a fixed constant. We will soon see what that choice entails!

LR test for the Gaussian mean

• example 1: let (X_1, \ldots, X_n) be a random sample from a $N(\mu, 1)$ population and consider testing $\mathbb{H}_0: \mu = \mu_0$ versus $\mathbb{H}_1: \mu \neq \mu_0$, then

$$\begin{split} \lambda(\mathbf{x}) &= \frac{\ell(\mu_0|\mathbf{x})}{\ell(\bar{x}_n|\mathbf{x})} &= \frac{(2\pi)^{-n/2}\exp\left[-\sum_{i=1}^n(x_i-\mu_0)^2/2\right]}{(2\pi)^{-n/2}\exp\left[-\sum_{i=1}^n(x_i-\bar{x}_n)^2/2\right]} \\ &= \exp\left[-\frac{\sum_{i=1}^n(x_i-\mu_0)^2-\sum_{i=1}^n(x_i-\bar{x}_n)^2}{2}\right] \\ &= \exp\left[-\frac{n(\bar{x}_n-\mu_0)^2}{2}\right], \end{split}$$

and for $\lambda(\mathbf{x}) = c$,

$$\ln c = -\frac{n(\bar{x}_n - \mu_0)^2}{2} \Rightarrow (\bar{x}_n - \mu_0)^2 = -2(\ln c)/n$$

yielding a rejection region

$$\{\boldsymbol{x}:\,\lambda(\boldsymbol{x})\leq \boldsymbol{c}\}=\left\{\boldsymbol{x}:\,|\bar{\boldsymbol{x}}_n-\mu_0|\geq\sqrt{-2(\ln\boldsymbol{c})/n}\right\}$$

size of a LR test

- in general, to derive a size α LR test that rejects the null H₀: θ ∈ Θ₀ if λ(x) ≤ c, we choose c such that sup_{θ∈Θ0} P_θ(λ(x) ≤ c) = α
- example 1 (cont'd): let $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$ and consider testing $\mathbb{H}_0: \mu = \mu_0$ using a LR test that rejects if $|\bar{x}_n \mu_0| \ge \sqrt{-2(\ln c)/n}$. Then

$$\mathbb{P}\left(|\bar{x}_n - \mu_0| \ge \sqrt{-2(\ln c)/n}\right) = \mathbb{P}\left(\frac{|\bar{x}_n - \mu_0|}{1/\sqrt{n}} \ge \sqrt{-2(\ln c)}\right) = \alpha$$

and since $\frac{\bar{x}_n - \mu_0}{1/\sqrt{n}} \sim N(0, 1)$ we can choose c such that $\sqrt{-2(\ln c)}$ yields the probability above being equal to α . This will be obtained at $\sqrt{-2(\ln c)} = z_{\alpha/2}$, which implies

$$c = \exp(-z_{\alpha/2}^2/2)$$

LR test for the exponential distribution

• example 2: let (X_1, \ldots, X_n) be a random sample from an exponential population with pdf

$$f(x_i| heta) = egin{cases} {\mathsf e}^{-(x_i- heta)} & x_i \geq heta\ 0 & x_i < heta \end{cases}$$

so the likelihood function is

$$f(\mathbf{x}| heta) = egin{cases} e^{-(\sum x_i - n heta)} & x_{(1)} \geq heta \ 0 & x_{(1)} < heta \ \end{pmatrix}$$

and consider testing $\mathbb{H}_0: \theta \leq \theta_0$ versus $\mathbb{H}_1: \theta > \theta_0$

if x₍₁₎ ≥ θ, ℓ(θ|x) = Πⁿ_{i=1} f(x_i|θ) is an increasing function of θ. Then unrestricted maximum is obtained at θ̂ = x₍₁₎ with maximum

$$\ell(\hat{\theta}|\mathbf{x}) = \ell(x_{(1)}|\mathbf{x}) = e^{-(\sum x_i - nx_{(1)})}$$
LR test for the exponential distribution

• now for the restricted maximum $\ell(\hat{ heta}_0|\mathbf{x})$

- if $x_{(1)} \leq heta_0$, then restriction is not binding and $\ell(\hat{ heta}_0|m{x}) = \ell(\hat{ heta}|m{x})$

$$-$$
 if $x_{(1)} > heta_0$, then $\hat{ heta}_0 = heta_0$ and $\ell(heta_0 | m{x}) = e^{-(\sum x_i - n heta_0)}$

• the likelihood test statistic is



Figure 8.2.1. $\lambda(\mathbf{x})$, a function only of $x_{(1)}$.

LR test for the exponential distribution

• therefore, a test that rejects \mathbb{H}_0 if $\lambda(\boldsymbol{X}) \leq c$ is such that

$$e^{-n(x_{(1)}-\theta_0)} \leq c \Rightarrow -n(x_{(1)}-\theta_0) \leq \ln c \Rightarrow x_{(1)} \geq \theta_0 - \frac{\ln c}{n}$$

rejection region $\{x : \lambda(x) \leq c\} = \{x : x_{(1)} \geq \theta_0 - (\ln c)/n\}$

• now find c that matches a desired size α . General fact:

$$\mathbb{P}(X_i \leq k) = \int_{\theta_0}^k e^{-(x-\theta_0)} dx = \left[-e^{-(x-\theta_0)}\right]_{\theta_0}^k = 1 - e^{-(x-\theta_0)}$$

therefore the probability that all X_1, \ldots, X_n are greater than k is

$$\mathbb{P}\left(X_{(1)} \geq k\right) = e^{-n(k-\theta_0)}$$

• in the test, $k = \theta_0 - (\ln c)/n$, so we must choose c such that

$$e^{-n(\theta_0 - (\ln c)/n - \theta_0)} = \alpha$$

which just implies that $c = \alpha$.

sufficient statistics are sufficient for LR tests

- is it a coincidence that likelihood ratio tests on the normal and exponential depended on sufficient statistics (respectively, \bar{x}_n and $x_{(1)}$)?
- if *T*(*X*) is a sufficient statistic for θ with pdf/pmf g(t|θ), then LR tests based on *T* and its likelihood function ℓ_{*}(θ|t) = g(t|θ) should be as good as LR tests based on ℓ(θ|*x*)
- theorem (equivalence): $\lambda_*(T(\mathbf{x})) = \lambda(\mathbf{x})$ for every \mathbf{x} in the sample space if $T(\mathbf{X})$ is a sufficient statistic for θ
- proof: it follows from the factorization theorem that

$$\lambda(\mathbf{x}) = \frac{\sup_{\theta \in \Theta_{\mathbf{0}}} \ell(\theta | \mathbf{x})}{\sup_{\theta \in \Theta} \ell(\theta | \mathbf{x})} = \frac{\sup_{\theta \in \Theta_{\mathbf{0}}} g(T(\mathbf{x}) | \theta) h(\mathbf{x})}{\sup_{\theta \in \Theta} g(T(\mathbf{x}) | \theta) h(\mathbf{x})} = \frac{\sup_{\theta \in \Theta_{\mathbf{0}}} \ell_{*}(\theta | T(\mathbf{x}))}{\sup_{\theta \in \Theta} \ell_{*}(\theta | T(\mathbf{x}))} = \lambda_{*}(T(\mathbf{x}))$$

nuisance parameters do not annoy so much

- likelihood tests are also convenient if there are nuisance parameters, that is to say, parameters for which we have no inferential interest
- they do not affect the LR test construction method, though their presence might result in a different test
- example: suppose $X_1, \ldots, X_n \sim \text{iid } N(\mu, \sigma^2)$ and that we wish to test $\mathbb{H}_0: \mu \leq \mu_0$ against $\mathbb{H}_1: \mu > \mu_0$

$$\begin{split} \lambda(\mathbf{x}) &= \frac{\max_{\mu \leq \mu_{\mathbf{0}}, \sigma^{2} \geq 0} \ell(\mu, \sigma^{2} | \mathbf{x})}{\max_{\mu \in \mathbb{R}, \sigma^{2} \geq 0} \ell(\mu, \sigma^{2} | \mathbf{x})} \\ &= \frac{\max_{\mu \leq \mu_{\mathbf{0}}, \sigma^{2} \geq 0} \ell(\mu, \sigma^{2} | \mathbf{x})}{\ell(\bar{x}_{n}, \hat{\sigma}^{2} | \mathbf{x})} \\ &= \begin{cases} 1 & \text{if } \bar{x}_{n} \leq \mu_{0} \\ \frac{\ell(\mu_{\mathbf{0}}, \hat{\sigma}^{2} | \mathbf{x})}{\ell(\bar{x}_{n}, \hat{\sigma}^{2} | \mathbf{x})} & \text{if } \bar{x}_{n} > \mu_{0} \end{cases} \end{split}$$

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4. exercises

\mathbb{H}_{0}	\mathbb{H}_{1}	UMP test?	example of <i>R</i>
$\mu = \mu_0$	$\mu = \mu_1$		
$\mu=\mu_{0}$	$\mu > \mu_1$		
$\mu \leq \mu_{0}$	$\mu > \mu_{0}$		
$\mu=\mu_{0}$	$\mu eq \mu_{0}$		

most powerful tests

- general principle: a good test should have for a given probability of type-I error the smallest possible probability of type-II error
- definition: unbiased tests are more likely to reject \mathbb{H}_0 if the null is false than if it is true, and hence their power functions are such that $\beta(\theta_1) \geq \beta(\theta_0)$ if $\theta_0 \in \Theta_0$ and $\theta_1 \in \Theta_1$



(un)biased tests here?

most powerful tests

- definition: let C be a class of tests for $\mathbb{H}_0: \theta \in \Theta_0$ versus $\mathbb{H}_1: \theta \in \Theta_1$, then a test in C with power function $\beta(\theta)$ is a uniformly most powerful class C test if $\beta(\theta) \ge \tilde{\beta}(\theta)$ for every $\theta \in \Theta_1$ and every $\tilde{\beta}(\theta)$ that is a power function of a test in class C
- we typically consider the class ${\cal C}$ of all level α tests, because we have to control anyway the probability of type I error



which one is most powerful?

```
mu
```

Neyman-Pearson lemma

theorem (Neyman-Pearson lemma) (CB 8.3.12): consider testing ℍ₀: θ = θ₀ versus ℍ₁: θ = θ₁, where the pdf/pmf corresponding to θ_i is f(x|θ_i) for i = 0, 1 using a test with rejection region R such that

$\pmb{x}\in \pmb{R}$	if	$f(\mathbf{x} \theta_1) > kf(\mathbf{x} \theta_0)$
$\pmb{x}\in \pmb{R}^{c}$	if	$f(\boldsymbol{x} \theta_1) < kf(\boldsymbol{x} \theta_0)$

for some $k \geq 0$, and $\mathbb{P}_{\theta_0}(X \in R) = \alpha$, then

- (i) (Sufficiency) such a test is a UMP level α test
- (ii) (Necessity) if there exists such a test, then every UMP level α test is a size α test
- (iii) (Necessity) every UMP level α test has a rejection region of the above form, except perhaps on a set A of null measure under θ_0 and θ_1 : $\mathbb{P}_{\theta_0}(\mathbf{X} \in A) = \mathbb{P}_{\theta_1}(\mathbf{X} \in A) = 0$
- remember: for $0 \le \alpha \le 1$, a test with power function $\beta(\theta)$ has size α if

$$\sup_{\boldsymbol{\theta}\in\Theta_{\mathbf{0}}}\beta(\boldsymbol{\theta})=\alpha$$

whereas it has level α if $\sup_{\theta \in \Theta_0} \beta(\theta) \leq \alpha$

Neyman-Pearson lemma

- proof (i): let φ(x) denote the test function of the Neyman-Pearson test, taking value 1 if x ∈ R and zero if x ∈ R^c, and φ̃(x) any other level α test function 0 ≤ φ̃(x) ≤ 1
- the Neyman-Pearson rejection region implies that, for every sample point x,

$$0 \leq \left[\phi(\mathbf{x}) - ilde{\phi}(\mathbf{x})
ight] \left[f(\mathbf{x}| heta_1) - kf(\mathbf{x}| heta_0)
ight]$$

and hence

$$0 \leq \int \left[\phi(\mathbf{x}) - \tilde{\phi}(\mathbf{x})\right] \left[f(\mathbf{x}|\theta_1) - kf(\mathbf{x}|\theta_0)\right] d\mathbf{x}$$

= $\beta(\theta_1) - \tilde{\beta}(\theta_1) - k\left[\beta(\theta_0) - \tilde{\beta}(\theta_0)\right]$
= $\beta(\theta_1) - \tilde{\beta}(\theta_1) - k\left[\alpha - \tilde{\beta}(\theta_0)\right]$
 $\leq \beta(\theta_1) - \tilde{\beta}(\theta_1)$

for $k \ge 0$ given that $\alpha - \tilde{\beta}(\theta_0) \ge 0$, hence $\beta(\theta_1) \ge \tilde{\beta}(\theta_1)$. That is, the NP test has greater power than any other test.

Neyman-Pearson lemma

• proof (ii): let now $\tilde{\phi}(\mathbf{x})$ denote any UMP level α test function and note that, by sufficiency, $\phi(\mathbf{x})$ is also UMP level α test. Because ϕ and $\tilde{\phi}$ are both UMP tests, $\beta(\theta_1) = \tilde{\beta}(\theta_1)$, it then follows from

$$eta(heta_1) - ildeeta(heta_1) - k ig[eta(heta_0) - ildeeta(heta_0)ig] \ge 0$$

with k > 0 that $-k \big[\beta(\theta_0) - \tilde{\beta}(\theta_0) \big] \ge 0 \Rightarrow \beta(\theta_0) - \tilde{\beta}(\theta_0) \le 0$. Then

$$0 \leq lpha - ilde{eta}(heta_0) = eta(heta_0) - ilde{eta}(heta_0) \leq 0$$

and hence $\tilde{\beta}(\theta_0) = \alpha$ and $\tilde{\phi}$ is in fact a size α test.

proof (iii): this implies that

$$\underbrace{\beta(\theta_1) - \tilde{\beta}(\theta_1)}_{=0} - k \underbrace{\left[\beta(\theta_0) - \tilde{\beta}(\theta_0)\right]}_{=0} = \int \left[\phi(\mathbf{x}) - \tilde{\phi}(\mathbf{x})\right] \left[f(\mathbf{x}|\theta_1) - kf(\mathbf{x}|\theta_0)\right] d\mathbf{x}$$

which implies only if $\tilde{\phi}$ has the same rejection region of the Neyman-Pearson test, except on a set A with $\int_A f(\mathbf{x}|\theta_i) dx = 0, \forall i = 1, 2$.

example

• example 1 (CB 8.20): let X be a random variable with distribution under \mathbb{H}_0 and \mathbb{H}_1 given by

х	1	2	3	4	5	6	7
$f(x \mathbb{H}_0)$	0.01	0.01	0.01	0.01	0.01	0.01	0.94
$f(x \mathbb{H}_1)$	0.06	0.05	0.04	0.03	0.02	0.01	0.79

use the Neyman-Pearson lemma to find the most powerful test for \mathbb{H}_0 against \mathbb{H}_1 with size $\alpha = 0.04$. Compute the probability of type-II error.

• solution: by the NP lemma, we should define the rejection region

$$\mathbf{x} \in R$$
 if $f(\mathbf{x}|\theta_1) > kf(\mathbf{x}|\theta_0)$

that is, $\frac{f(\mathbf{x}|\theta_1)}{f(\mathbf{x}|\theta_0)} > k$. $\frac{\mathbf{x} \quad 1 \quad 2 \quad 3 \quad 4 \quad 5 \quad 6 \quad 7}{\frac{f(\mathbf{x}|\mathbb{H}_1)}{f(\mathbf{x}|\mathbb{H}_0)} \quad 6 \quad 5 \quad 4 \quad 3 \quad 2 \quad 1 \quad 0.84}$

so rejecting for large values of k corresponds to small values of x. A test with size $\alpha = 0.04$ is such that $\mathbb{P}(X \leq c | \mathbb{H}_0) = 0.04$, which is achieved at c = 4. The type-II error is $\mathbb{P}(X \in \{5, 6, 7\} | \mathbb{H}_1) = .82$.

UMP test for the binomial probability

example 2: let X ~ Bin(2, p) and consider testing ℍ₀: p = 1/2 against ℍ₁: p = 3/4 using the pmf ratios

$$\frac{f\left(0|p=\frac{3}{4}\right)}{f\left(0|p=\frac{1}{2}\right)} = \frac{\frac{1}{4}\frac{1}{4}}{\frac{1}{2}\frac{1}{2}} = \frac{1}{4} \quad ; \quad \frac{f\left(1|p=\frac{3}{4}\right)}{f\left(1|p=\frac{1}{2}\right)} = \frac{2\frac{1}{4}\frac{3}{4}}{2\frac{1}{2}\frac{1}{2}} = \frac{3}{4} \quad ; \quad \frac{f\left(2|p=\frac{3}{4}\right)}{f\left(2|p=\frac{1}{2}\right)} = \frac{\frac{3}{4}\frac{3}{4}}{\frac{1}{2}\frac{1}{2}} = \frac{9}{4}$$

• if we choose...

$$\begin{array}{rcl} -& k > \frac{9}{4} \text{ yields the UMP with level } \alpha = 0 \\ -& \frac{3}{4} < k < \frac{9}{4}, \text{ the test that rejects } \mathbb{H}_0 \text{ if } X = 2 \text{ is UMP with level} \\ & \alpha & = & \mathbb{P}\left(X = 2|\theta = \frac{1}{2}\right) & = & \frac{1}{4} \\ -& \frac{1}{4} < k < \frac{3}{4}, \text{ the test that rejects } \mathbb{H}_0 \text{ if } X = \{1,2\} \text{ is UMP with level} \\ & \alpha & = & \mathbb{P}\left(X = 1 \text{ or } 2|\theta = \frac{1}{2}\right) & = & \frac{3}{4} \end{array}$$

 $-~k<\frac{1}{4}$ yields the UMP with level $\alpha=1$

how about sufficiency?

• corollary of NP lemma (CB 8.3.13): suppose T(X) is sufficient for θ , with pdf/pmf $g(t|\theta_i)$ corresponding to θ_i (i = 0, 1), then any test based on T(X) with rejection region S such that

 $egin{array}{ll} t\in \mathcal{S} & ext{if} & g(t| heta_1)>kg(t| heta_0) \ t\in \mathcal{S}^c & ext{if} & g(t| heta_1)<kg(t| heta_0) \end{array}$

for some $k \geq 0$, where $\mathbb{P}_{\theta_0}(\mathcal{T}(\mathbf{x}) \in S) = \alpha$, is a UMP level α test.

• proof: in terms of the original sample X, the test based on T(X) has rejection region $R = \{x : T(x) \in S\}$ such that

$$\begin{aligned} \mathbf{x} \in R & \text{if} \quad f(\mathbf{x}|\theta_1) = g\left(T(\mathbf{x})|\theta_1\right)h(\mathbf{x}) > kg\left(T(\mathbf{x})|\theta_0\right)h(\mathbf{x}) = kf(\mathbf{x}|\theta_0) \\ \mathbf{x} \in R^c & \text{if} \quad f(\mathbf{x}|\theta_1) = g\left(T(\mathbf{x})|\theta_1\right)h(\mathbf{x}) < kg\left(T(\mathbf{x})|\theta_0\right)h(\mathbf{x}) = kf(\mathbf{x}|\theta_0) \end{aligned}$$

and $\mathbb{P}_{\theta_0}(X \in R) = \mathbb{P}_{\theta_0}(T(X) \in S)$, so it is also a UMP level α test by the Neyman-Pearson lemma.

UMP test for the normal mean

• example 3: let $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$ and consider testing $\mathbb{H}_0: \mu = \mu_0$ against $\mathbb{H}_1: \mu = \mu_1$, with $\mu_0 > \mu_1$. We had that

$$f(\mathbf{x}|\mu,\sigma^2) = (2\pi\sigma^2)^{-n/2} \exp\left\{-\frac{\sum_{i=1}^n (x_i - \bar{x}_n)^2 + n(\bar{x}_n - \mu)^2}{2\sigma^2}\right\}$$

so, applying the NP lemma,

$$\frac{f(\boldsymbol{x}|\mu_{1},1)}{f(\boldsymbol{x}|\mu_{0},1)} = \exp\left\{\frac{n(\bar{x}_{n}-\mu_{0})^{2}-n(\bar{x}_{n}-\mu_{1})^{2}}{2\sigma^{2}}\right\} > k$$

so that $(\bar{x}_n - \mu_0)^2 - (\bar{x}_n - \mu_1)^2 > \frac{1}{n} 2\sigma^2 \ln k$. We need to isolate \bar{x}_n :

$$(\bar{x}_n - \mu_0)^2 - (\bar{x}_n - \mu_1)^2 = \bar{x}_n^2 - 2\bar{x}_n\mu_0 + \mu_0^2 - \bar{x}_n^2 + 2\bar{x}_n\mu_1 - \mu_1^2$$

= $-2\bar{x}_n\mu_0 + \mu_0^2 + 2\bar{x}_n\mu_1 - \mu_1^2$

and given that $\mu_1 - \mu_0 < 0$, the rejection region is of the format

$$\bar{x}_n < \frac{\frac{1}{n}2\sigma^2 \ln k - \mu_0^2 + \mu_1^2}{2(\mu_1 - \mu_0)} \iff \bar{x}_n < c$$

UMP test for the normal mean

• example 3 (cont'd): for $\mu_0 = 0$, n = 100 and $\sigma^2 = 1$, this function looks like



equivalent to say that, for any k, there is a c such that $\bar{x}_n < c$. This means that a test with rejection region

$$\bar{x}_n < c = heta_0 - rac{\sigma z_lpha}{\sqrt{n}}$$

is the UMP level α test.

composite hypothesis

- 𝕮₀ and 𝕮₁ in the Neyman-Pearson lemma are simple hypotheses in that they specify only one possible distribution for sample *X*, i.e., 𝔅₀ and 𝔅₁ are singletons.
- composite hypotheses: in most realistic problems, the hypotheses of interest specify more than one possible distribution for the sample

one-sided tests:	$\mathbb{H}_{0}:\mu\leq\mu_{0}$	VS	$\mathbb{H}_{1}: \mu > \mu_{0}$
two-sided tests:	$\mathbb{H}_{0}: \mu = \mu_{0}$	vs	$\mathbb{H}_{1}: \mu \neq \mu_{0}$

• is the Neyman-Pearson lemma applicable? We shall defer this question to when we talk about union-intersection tests.

one-sided tests

- a large class of problems that admit UMP level α tests involve one-sided hypotheses and pdfs/pmfs with the monotone LR property
- definition: a family of pdfs/pmfs {g(t|θ) : θ ∈ Θ} for a univariate random variable T with parameter θ ∈ ℝ has a monotone likelihood ratio if for every θ₂ > θ₁, g(t|θ₂)/g(t|θ₁) is a monotone function of t on {t : g(t|θ₁) > 0 or g(t|θ₂) > 0}
- interestingly, any exponential family with g(t|θ) = h(t)c(θ) exp {w(θ)t} has an MLR if w(θ) is nondecreasing
- theorem (Karlin-Rubin) (CB 8.3.17): consider testing $\mathbb{H}_0: \theta \leq \theta_0$ versus $\mathbb{H}_1: \theta > \theta_0$ using a sufficient statistic T whose pdf/pmf satisfies the MLR property, then the UMP level α test rejects the null if $T > t_0$ with $\mathbb{P}_{\theta_0}(T > t_0) = \alpha$.

one-sided tests

- example: X_1, \ldots, X_n i.i.d. standard normal. Consider testing $\mathbb{H}'_0 : \theta \ge \theta_0$ versus $\mathbb{H}'_1 : \theta < \theta_0$.
- since \bar{X}_n is sufficient and distribution has a monotone likelihood ratio, we can apply the Karlin-Rubin theorem which states that we should reject the null if

$$\bar{x}_n < heta_0 - rac{\sigma z_{lpha}}{\sqrt{n}}$$

and the power function is

$$eta(heta) \;\;\;=\;\;\; \mathbb{P}_{ heta}\left(ar{X}_n < heta_{ extsf{0}} - rac{\sigma z_lpha}{\sqrt{n}}
ight)$$

which is a decreasing function of θ . The value α is given by

$$\sup_{\theta \ge \theta_0} \beta(\theta) = \beta(\theta_0) = \alpha$$

• example: let $\{X_1, \ldots, X_n\} \sim N(\mu, \sigma^2)$ i.i.d. with σ^2 known, and consider testing $\mathbb{H}_0 : \mu \leq 0$ against $\mathbb{H}_1 : \mu > 0$.

- test 1: take the test statistic $rac{ar{\chi}_n-\mu_0}{\sigma/\sqrt{n}}>c$, where $c=z_lpha$, with rejection region

$$R_1 = \left\{ X : \frac{\bar{X}_n - \mu_0}{\sigma/\sqrt{n}} > z_\alpha \right\} = \left\{ X : \bar{X}_n > \mu_0 + \sigma \frac{z_\alpha}{\sqrt{n}} \right\}$$

which is the UMP test of level α .

- test 2: using only the first 5 observations, also with level α

$$R_2 \quad = \quad \left\{ X : \frac{\bar{X}_5 - \mu_0}{\sigma/\sqrt{5}} > z_\alpha \right\} \quad = \quad \left\{ X : \bar{X}_5 > \mu_0 + \sigma \frac{z_\alpha}{\sqrt{5}} \right\}$$

• test 3:

$$R_3 = \left\{ X : \sum_{i=1}^n \frac{X_i^2}{\sigma^2} > \kappa \text{ if } \bar{X}_n > 0 \right\}$$

and we need to find κ such that the probability of rejecting is α .

$$\mathbb{P}(X \in R_3) \quad = \quad \mathbb{P}\left\{\left.\sum_{i=1}^n \frac{X_i^2}{\sigma^2} > \kappa \right| \bar{X}_n > 0\right\} \cdot \mathbb{P}\left(\bar{X}_n > 0\right)$$

while

$$\mathbb{P}\left(\bar{X}_n < 0\right) \quad = \quad \mathbb{P}\left(\sqrt{n}\frac{\bar{X}_n - \mu}{\sigma} < -\sqrt{n}\frac{\mu}{\sigma}\right) \quad = \quad \mathbb{P}\left(Z < \sqrt{n}\frac{\mu}{\sigma}\right)$$

given that $\sqrt{n}\frac{\bar{\chi}_n-\mu}{\sigma} \sim N(0,1)$. Conditional of $\bar{X}_n > 0$, $\sum_{i=1}^n \frac{\chi_i^2}{\sigma^2} \sim \chi_n^2$ from the χ_n^2 distribution, so we can find a $\kappa = q_{\alpha^*}$ such that $\mathbb{P}\left(\sum_{i=1}^n \frac{\chi_i^2}{\sigma^2} < q_{\alpha^*}\right) = \alpha^*$.

• taking $\mu=$ 0,

$$\mathbb{P}(X \in R_3) = 0.5(1 - \alpha^*) = \alpha \implies \alpha^* = 1 - 2\alpha$$

```
n < -500
sigma2 <- 1
alpha <- 0.05
m_{11} < - 0
test1 <- function(x){
  TS <- sqrt(n)*mean(x)/sqrt(sigma2)</pre>
  testOutcome <- (TS > qnorm(1-alpha))
}
test2 <- function(x){
  TS <- sqrt(5)*mean(x[1:5])/sqrt(sigma2)</pre>
  testOutcome <- (TS > qnorm(1-alpha))
}
test3 <- function(x){</pre>
  TS <- sum(x^2/sigma2)
  testOutcome <- (TS > qchisq(1-2*alpha,n))
  if (mean(x) < 0) {testOutcome=0}</pre>
  testOutcome
}
```

```
testRejFreq <- function(mu){
   testRej <- matrix(0,5000,3)
   for (i in 1:5000){
        x <- rnorm(n,mean=mu,sd=sqrt(sigma2))
        testRej[i,1] <- test1(x)
        testRej[i,2] <- test2(x)
        testRej[i,3] <- test3(x)
   }
   testRejF <- colMeans(testRej)
}
mu <- seq(-1,2.5,by=0.1)</pre>
```

table: rejection frequencies

<i>n</i> = 50							
	$\mu = 0$	$\mu = 0.1$	$\mu = 0.2$	$\mu = 0.5$	$\mu = 1$		
test 1	0.0472	0.1706	0.4078	0.9702	1.0000		
test 2	0.0444	0.0714	0.1168	0.3094	0.7284		
test 3	0.0478	0.0840	0.1376	0.4570	0.9916		
n = 500							
	$\mu = 0$	$\mu = 0.1$	$\mu = 0.2$	$\mu = 0.5$	$\mu = 1$		
test 1	0.0534	0.7218	0.9986	1.0000	1.0000		
test 2	0.0484	0.0800	0.1214	0.3060	0.6436		
test 3	0.0500	0.1376	0.2576	0.9872	1.0000		



mu

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• summary of results so far

\mathbb{H}_{0}	\mathbb{H}_{1}	UMP test?	example of <i>R</i>
$\mu = \mu_0$	$\mu = \mu_1$	Neyman-Person lemma	$\bar{x}_n < c$
$\mu=\mu_{0}$	$\mu > \mu_1$	(deferred)	
$\mu \leq \mu_{0}$	$\mu > \mu_{0}$	Karlin-Rubin theorem	$\bar{x}_n < c$
$\mu=\mu_{0}$	$\mu eq \mu_{0}$	explore now	

UMPU tests

- if there is no UMP level α test within the class of all tests, we might try to find a UMP level α test within the class of unbiased tests.
- the next example shows that it is not trivial to find an UMP test within the class of α-sized tests.
- example: let $X_1, \ldots, X_n \sim N(\mu, \sigma^2)$ i.i.d. with σ^2 known, and consider testing $\mathbb{H}_0: \mu = \mu_0$ versus $\mathbb{H}_1: \mu \neq \mu_0$.

- test 1: rejects \mathbb{H}_0 if $\bar{X}_n < \mu_0 - \frac{\sigma z_\alpha}{\sqrt{n}}$. The power function is for the test with size α is

$$\begin{split} \beta_1(\mu) &= \mathbb{P}_{\mu}\left(\bar{X}_n < \mu_0 - \frac{\sigma z_{\alpha}}{\sqrt{n}}\right) &= \mathbb{P}_{\mu}\left(\bar{X}_n - \mu < \mu_0 - \mu - \frac{\sigma z_{\alpha}}{\sqrt{n}}\right) \\ &= \mathbb{P}_{\mu}\left(\frac{\bar{X}_n - \mu}{\sigma/\sqrt{n}} < -z_{\alpha} + \frac{\mu_0 - \mu}{\sigma/\sqrt{n}}\right) &= \mathbb{P}\left(Z > z_{\alpha} - \frac{\mu_0 - \mu}{\sigma/\sqrt{n}}\right) \end{split}$$

UMPU tests

• example (cont'd): test 2: rejects \mathbb{H}_0 if $\bar{X}_n > \mu_0 + \frac{\sigma z_\alpha}{\sqrt{n}}$

$$eta_2(\mu) \quad = \quad \mathbb{P}\left(Z > z_lpha + rac{\mu_0 - \mu}{\sigma/\sqrt{n}}
ight)$$

and take a point $\mu_1 < \mu_0$

$$\beta_1(\mu_1) = \mathbb{P}\left(Z > z_\alpha - \frac{\mu_0 - \mu_1}{\sigma/\sqrt{n}}\right) > \mathbb{P}\left(Z > z_\alpha + \frac{\mu_0 - \mu_1}{\sigma/\sqrt{n}}\right) = \beta_2(\mu_1)$$

because $\mu_0 - \mu_1 > 0$. Now, if $\mu_2 > \mu_0$, we will have that $\mu_0 - \mu_2 < 0$ and the inequality will reverse, that is, $\beta_1(\mu_2) < \beta_2(\mu_2)$.

UMPU tests

• the problem is that the class of tests is too wide: we may restrict the class of tests to search among α-level unbiased tests.



- it happens that this test is the UMP test
- note that there is a loss of power compared to tests 1 and 2 at some parameter points

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union-intersection tests

- in some situations, tests for complicated null hypotheses can be developed from tests for simpler null hypotheses
- suppose that the null hypothesis can be conveniently expressed as

$$\mathbb{H}_{\mathbf{0}} \colon \boldsymbol{\theta} \in \bigcap_{\gamma \in \mathsf{\Gamma}} \Theta_{\gamma}$$

and there are tests available for each testing problem $\mathbb{H}_{0}^{(\gamma)}: \boldsymbol{\theta} \in \Theta_{0}^{\gamma}$ versus $\mathbb{H}_{1}^{(\gamma)}: \boldsymbol{\theta} \in \Theta_{1}^{\gamma}$, with rejection regions $\{\boldsymbol{x}: T_{\gamma}(\boldsymbol{x}) \in R_{\gamma}\}$

- if any hypothesis $\mathbb{H}_0^{(\gamma)}$ is rejected, then \mathbb{H}_0 must also be rejected. Then the rejection region for the UI test is $\bigcup_{\gamma \in \Gamma} \{x : T_{\gamma}(x) \in R_{\gamma}\}$
- in some situations, it is possible to simplify the expression for the rejection region of a union-intersection test

$$\bigcup_{\gamma\in\Gamma} \left\{ \boldsymbol{x}: \ T_{\gamma}(\boldsymbol{x})\in R_{\gamma} \right\} = \left\{ \boldsymbol{x}: \sup_{\gamma\in\Gamma} T_{\gamma}(\boldsymbol{x}) > \boldsymbol{c} \right\}$$

and hence $T(x) = \sup_{\gamma \in \Gamma} T_{\gamma}(x)$

Gaussian union-intersection tests

- example: let $X_1, \ldots, X_n \sim \text{iid } N(\mu, \sigma^2)$ and consider testing $\mathbb{H}_0 : \mu = \mu_0$ against $\mathbb{H}_1 : \mu \neq \mu_0$
- we may write the null hypothesis as the intersection of \mathbb{H}_0^L : $\{\mu : \mu \leq \mu_0\}$ and \mathbb{H}_0^U : $\{\mu : \mu \geq \mu_0\}$

$$\mathsf{LR tests} \begin{cases} \mathsf{reject} \ \mathbb{H}_0^L \colon \ \mu \leq \mu_0 \ \text{ if } \ \sqrt{n} \ \frac{\bar{X}_n - \mu_0}{S_n} \geq t_L \\ \mathsf{reject} \ \mathbb{H}_0^U \colon \ \mu \geq \mu_0 \ \text{ if } \ \sqrt{n} \ \frac{\bar{X}_n - \mu_0}{S_n} \leq t_U \end{cases}$$

• union-intersection test

$$\text{reject }\mathbb{H}_0\colon \ \mu=\mu_0 \ \text{ if } \ t_L \leq \sqrt{n} \, \frac{\bar{X}_n-\mu_0}{S_n} \ \text{ or } \ \sqrt{n} \, \frac{\bar{X}_n-\mu_0}{S_n} \leq t_U,$$

which coincides with the two-sided LR t-test if $t_L = -t_U \ge 0$ and then we can write

reject
$$\mathbb{H}_0$$
: $\mu = \mu_0$ if $\sqrt{n} \frac{|\bar{X}_n - \mu_0|}{S_n} \ge t_L$

which is also called the two-sided *t*-test

union-intersection test and Neyman-Pearson lemma

• let $X_1, \ldots, X_n \sim \text{iid } N(\mu, 1)$. From the NP lemma, the α -level uniformly most powerful test for $\mathbb{H}_0: \mu = \mu_0$ against $\mathbb{H}_1: \mu = \mu_1, \mu_1 < \mu_0$, has rejection region

$$R = \left\{ x : \bar{x}_n < \mu_0 - \frac{\sigma z_\alpha}{\sqrt{n}} \right\}$$

• now consider testing $\mathbb{H}_0: \mu = \mu_0$ against $\mathbb{H}_1: \mu < \mu_0$. We can write

$$\begin{aligned} \mathbb{H}_{\mathbf{0}}^{(\gamma)} &: \quad \mu = \mu_{\mathbf{0}} \\ \mathbb{H}_{\mathbf{1}}^{(\gamma)} &: \quad \mu = \gamma \end{aligned}$$

with $\gamma \in \Gamma = \{\gamma : \gamma < \mu_0, \gamma \in \mathbb{R}\}$, which is a union-intersection test.

• notice that, for each of these tests, the rejection region R is unchanged. It follows that the rejection region for the UI test is

$$igcup_{\gamma\in\Gamma}\{m{x}:\ T_\gamma(m{x})\in R_\gamma\}\ =\ R$$

and also $\sup_{\gamma \in \Gamma} T_{\gamma}(x) = T(x)$.

• note that each of those tests are the UMP test individually.. it follows that rejection region *R* also constitutes the UMP for the composite hypothesis!

intersection-union tests

• suppose that we may conveniently express the null as a union

$$\mathbb{H}_{\mathbf{0}} \colon \boldsymbol{\theta} \in \bigcup_{\gamma \in \Gamma} \Theta_{\gamma}$$

and there are tests available for each testing problem $\mathbb{H}_{0}^{(\gamma)}: \boldsymbol{\theta} \in \Theta_{0}^{\gamma}$ versus $\mathbb{H}_{1}^{(\gamma)}: \boldsymbol{\theta} \in \Theta_{1}^{\gamma}$, with rejection regions $\{\boldsymbol{x}: T_{\gamma}(\boldsymbol{x}) \in R_{\gamma}\}$

- if all hypotheses $\mathbb{H}_{0}^{(\gamma)}$ is rejected, then \mathbb{H}_{0} must be rejected. The rejection region for the IU test is $\bigcap_{\gamma \in \Gamma} \{x : T_{\gamma}(x) \in R_{\gamma}\}$
- in some situations, it is possible to simplify the expression for the rejection region of a intersection-union test

$$igcap_{\gamma\in\Gamma}ig\{m{x}:\ T_\gamma(m{x})\in R_\gammaig\}\ =\ ig\{m{x}:\ \inf_{\gamma\in\Gamma}T_\gamma(m{x})\geq cig\}$$

and hence $T(\mathbf{x}) = \inf_{\gamma \in \Gamma} T_{\gamma}(\mathbf{x})$

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p-values

- so far, a statistical test would report only whether \mathbb{H}_0 got accepted or rejected at a certain α -level, but not by how much
- *p*-values are another way of conveying information about the outcome of the statistical test: what is the minimum α such that \mathbb{H}_0 is rejected?

 $\begin{array}{l} \mathbb{H}_{0} \text{ rejected } \alpha = 0.10 \\ \mathbb{H}_{0} \text{ rejected at } \alpha = 0.05 \\ \mathbb{H}_{0} \text{ not rejected at } \alpha = 0.01 \end{array}$

so lower values are indicative of "more convincing" rejections

• definition: the p-value is the smallest significance level such that x is in the rejection region

 $p(\mathbf{x}) = \inf\{\alpha : \mathbf{x} \in R_{\alpha}\}$

where R_{α} is the rejection region at significance level α

p-values

example: take our well-known right-tailed rejection region

$$R_{\alpha} = \left\{ x: rac{ar{x}_n - \mu_0}{\sigma/\sqrt{n}} > z_{1-lpha}
ight\}$$

for the test of $\mathbb{H}_0: \mu \leq \mu_0$ against $\mathbb{H}_1: \mu > \mu_0$. Note that

$$\left\{x:\frac{\bar{x}_n-\mu_0}{\sigma/\sqrt{n}}>z_{1-\alpha}\right\} = \left\{x:1-\Phi\left(\frac{\bar{x}_n-\mu_0}{\sigma/\sqrt{n}}\right)>1-\alpha\right\}$$

for a given x, the *p*-value is the infimum α such that $1 - \Phi\left(\frac{\bar{x}_n - \mu_0}{\sigma/\sqrt{n}}\right) > 1 - \alpha$ holds,

$$p = \Phi\left(\frac{\bar{x}_n - \mu_0}{\sigma/\sqrt{n}}\right)$$

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inference and set estimation

- we would like to make statements of the form $\theta \in C(x)$, where the set estimate $C(x) \subset \Theta$ depends only on the realization of the sample
- if θ is a scalar, C(x) will typically be an interval
- our goal is to build intervals in which the true parameter lies with a certain probability

 $\mathbb{P}\left(\mu = \bar{X}_n\right) = 0$ point estimation $\mathbb{P}\left(\mu \in C(\boldsymbol{X})\right) \geq 0$ interval estimation

- definition: an interval estimate of a parameter $\theta \in \Theta \subset \mathbb{R}$ is any pair of statistics L(x) and U(x) that satisfy $L(x) \leq U(x)$ for all $x \in S_X$, whereas the random interval [L(X), U(X)] corresponds to the interval estimator
- it is possible that $L(\boldsymbol{X}) = -\infty$ or $U(\boldsymbol{X}) = \infty$
- · we will see soon that this topic is very much connected to hypothesis testing

interval coverage

• example: if $X_1, \ldots, X_4 \sim \text{iid } N(\mu, 1)$, $[\bar{X}_4 - 1, \bar{X}_4 + 1]$ is a interval estimator of μ . The probability that $\mu \in C(\mathbf{x})$ is

$$\begin{split} \mathbb{P}\big(\mu \in [\bar{X}_4 - 1, \bar{X}_4 + 1]\big) &= \mathbb{P}(\bar{X}_4 - 1 \leq \mu \leq \bar{X}_4 + 1) &= \mathbb{P}(|\bar{X}_4 - \mu| \leq 1) \\ &= \mathbb{P}\left(\frac{|\bar{X}_4 - \mu|}{1/\sqrt{4}} \leq \frac{1}{1/\sqrt{4}}\right) &= \mathbb{P}(|Z| \leq 2) &= 0.9544 \end{split}$$

- definition: the probability that the interval estimator [L(X), U(X)] of θ includes the true parameter value θ is the coverage probability
- definition: the confidence coefficient of [L(X), U(X)] is the infimum of the coverage probabilities, namely, inf_{θ∈Θ} ℙ_θ(θ ∈ [L(X), U(X)])
- since θ is unknown, the best we can offer is the infimum coverage probability, that is to say, the confidence coefficient
- keep in mind that the random quantity is the interval L(X) and U(X), but not θ , which is unknown but a fixed quantity
 - in the example above, the bounds depended on \bar{X}_n , which is a random quantity

scale uniform interval estimator

• example: let $X_1, \ldots, X_n \sim \text{iid U}(0, \theta)$ and consider $[aX_{(n)}, bX_{(n)}]$ with $1 \leq a < b$. The coverage probability is

$$\mathbb{P}_{ heta}\left(aX_{(n)} \leq heta \leq bX_{(n)}
ight) \quad = \quad \mathbb{P}\left(heta/b \leq X_{(n)} \leq heta/a
ight)$$

and cdf of $X_{(n)}$ is

$$\mathbb{P}\left(X_{(n)} \le k\right) = \prod_{i=1}^{n} \mathbb{P}\left(X_{i} \le k\right) = \prod_{i=1}^{n} \int_{0}^{k} \frac{1}{\theta} dx$$
$$= \prod_{i=1}^{n} \frac{k}{\theta} = \left[\frac{k}{\theta}\right]^{n}$$
$$\mathbb{P}\left(\theta/b \le X_{(n)} \le \theta/a\right) = \left[\frac{\theta/a}{\theta}\right]^{n} - \left[\frac{\theta/b}{\theta}\right]^{n} = a^{-n} - b^{-n}$$

scale uniform interval estimator

• example: (cont'd) consider alternatively $[X_{(n)} + c, X_{(n)} + d]$

$$\mathbb{P}_{ heta}(X_{(n)}+c\leq heta\leq X_{(n)}+d) &= \mathbb{P}_{ heta}\left(heta-d\leq X_{(n)}\leq heta-c
ight) \ &= \left[rac{ heta-c}{ heta}
ight]^n - \left[rac{ heta-d}{ heta}
ight]^n \ &= \left(1-c/ heta)^n - \left(1-d/ heta
ight)^n$$

which depends on θ , with confidence coefficient zero ($\theta \to \infty$)

interval estimator for a Gaussian sample mean

• example: if $X_1, \ldots, X_n \sim \text{iid } N(\mu, \sigma^2)$, σ^2 known. Consider testing $\mathbb{H}_0 : \mu = \mu_0$ against $\mathbb{H}_1 : \mu \neq \mu_0$. We would then typically use the rejection region

$$R = \left\{ X : |\bar{X}_n - \mu_0| > z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

since test has size lpha, $\mathbb{P}(x \in R^c | \mu = \mu_0) = 1 - lpha$. But

$$R^{c} = \left\{ X : |\bar{X}_{n} - \mu_{0}| < z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\} = \left\{ X : -z_{\alpha/2} \frac{\sigma}{\sqrt{n}} < \bar{X}_{n} - \mu_{0} < z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$
$$= \left\{ X : -\bar{X}_{n} - z_{\alpha/2} \frac{\sigma}{\sqrt{n}} < -\mu_{0} < -\bar{X}_{n} + z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$
$$= \left\{ X : \bar{X}_{n} - z_{\alpha/2} \frac{\sigma}{\sqrt{n}} < \mu_{0} < \bar{X}_{n} + z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

i.e., there is a probability $1-\alpha$ that $\mu_{\rm 0}$ is in the interval above.

interval estimator for a Gaussian sample mean

- there is a clear correspondence between confidence sets and tests
 - the acceptance region is a set in the sample space such that $\mathbb{H}_0: \mu = \mu_0$ is not rejected. It is a function of μ_0 , but not data

$$A(\mu_0) = \left\{ \mathbf{x} : \mu_0 - z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \le \bar{\mathbf{x}}_n \le \mu_0 + z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

 the confidence interval is set with plausible values of the parameters. It is a function of data, but not parameters

$$C(\mathbf{x}) = \left\{ \mu : \bar{x}_n - z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \le \mu \le \bar{x}_n + z_{\alpha/2} \frac{\sigma}{\sqrt{n}} \right\}$$

therefore

$$\boldsymbol{x} \in \boldsymbol{A}(\mu_{\boldsymbol{0}}) \iff \mu_{\boldsymbol{0}} \in \boldsymbol{C}(\boldsymbol{x})$$

interval estimator for a Gaussian sample mean



rejection regions and confidence intervals

• this notion can be made formal

• theorem (CB 9.2.2): for each $\theta_0 \in \Theta$, let $A(\theta_0)$ be the acceptance region of level α of $\mathbb{H}_0 : \theta = \theta_0$. For each $x \in \mathcal{X}$, define

$$C(\boldsymbol{x}) = \{\theta_0 : \boldsymbol{x} \in A(\theta_0)\}$$

then the random set C(X) is a $1 - \alpha$ confidence set. Conversely, let C(X) be a $1 - \alpha$ confidence set. Define

$$A(\theta_0) = \{x : \theta_0 \in C(x)\}$$

then $A(\theta_0)$ is the acceptance region of a level- α test with $\mathbb{H}_0: \theta = \theta_0$.

rejection regions and confidence intervals

• proof: $A(\theta_0)$ is acceptance region of a level- α test so $\mathbb{P}_{\theta_0}(\mathbf{X} \notin A(\theta_0)) \leq \alpha$ and $\mathbb{P}_{\theta_0}(\mathbf{X} \in A(\theta_0)) \geq 1 - \alpha$. Then

$$\mathbb{P}_{ heta}(heta\in {oldsymbol{C}}({oldsymbol{X}})) \;\;=\;\; \mathbb{P}_{ heta}({oldsymbol{X}}\in {oldsymbol{A}}(heta)) \;\;\geq\;\; 1-lpha$$

so $C(\mathbf{X})$ is a $1 - \alpha$ confidence set.

• the type-I error probability for $\mathbb{H}_0: \theta = \theta_0$ with acceptance region $A(\theta_0)$ is

$$\mathbb{P}_{\theta_{\mathbf{0}}}(\mathbf{X}\notin A(\theta_{\mathbf{0}})) = \mathbb{P}_{\theta_{\mathbf{0}}}(\theta_{\mathbf{0}}\notin C(\mathbf{X})) \leq \alpha$$

so this is a $\alpha\text{-level test.}$

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- two relevant quantities:
 - size of the interval: length or volume
 - coverage probability: probability that true parameter is in the set
- the latter is generally a function of the parameter, so we usually take the infimum over the parameter space.
 - this is the confidence coefficient
- we will soon see that performances of tests and set estimates are closely connected

- question: we can optimize the length of an interval while keeping coverage probability constant at 1-lpha?
- example: take X_1, \ldots, X_n iid $N(\mu, \sigma^2)$, σ known. Then

$$\mathbb{P}\left(\mathbf{a} \leq rac{ar{\mathcal{X}}_n - \mu}{\sigma/\sqrt{n}} \leq b
ight) = \mathbb{P}\left(\mathbf{a} \leq \mathbf{Z} \leq b
ight) = 1 - lpha$$

gives the confidence interval

$$\left\{\mu: \bar{x}_n - b\frac{\sigma}{\sqrt{n}} \le \mu \le \bar{x}_n - a\frac{\sigma}{\sqrt{n}}\right\}$$

- what choice of a and b minimizes length while keeping 1α coverage?
 - minimize b a with $\mathbb{P}(a \le Z \le b) = 1 \alpha$

а	Ь	P(Z < a)	P(Z > b)	b — a
-1.34	2.33	.09	.01	3.67
-1.44	1.96	.075	.025	3.40
-1.65	1.65	.05	.05	3.30

- table suggests that a = -b = 1.65 is the optimum
- it is not a requirement that the interval should symmetric: this is a consequence of the symmetry of the normal distribution

• theorem (CB 9.3.2): let f(x) be a unimodal pdf. If an interval [a, b] satisfies

(i)
$$\int_a^b f(x) dx = 1 - \alpha$$

(ii)
$$f(a) = f(b) > 0$$

(iii) $a \le x^* \le b$, where x^* is the mode of f(x)

then [a, b] is the shortest interval among all intervals such that $\int_a^b f(x) dx = 1 - \alpha$.

proof

optimality

- since there is a correspondence between confidence sets and hypothesis tests, there must be some correspondence between their optimalities
- consider a situation where $\mathbf{X} \sim f(\mathbf{x}|\theta)$ and construct a confidence set $C(\mathbf{X})$ for θ by inverting an acceptance region $A(\theta)$
- definition: the probability of true coverage is $\mathbb{P}_{\theta}(\theta \in C(X))$
- definition: the probability of false coverage is the probability that θ' is covered when θ is the true parameter

$$\mathbb{P}_{ heta}(heta'\in C(oldsymbol{X})) \quad ext{ if } \quad heta'
eq heta$$

• definition: the $1 - \alpha$ confidence set that minimizes the probability of false coverage is called the uniformly most accurate confidence set (UMA)

optimality

theorem (CB 9.3.5): let X ~ f(x|θ) where θ is real-valued. For each θ₀ ∈ Θ, let A*(θ₀) be the UMP level-α acceptance region of a test of H₀ : θ = θ₀ versus H₁ : θ > θ₀. Let C*(x) be the 1 - α confidence set formed by inverting the UMP acceptance regions. Then, for any other confidence region C(X),

$$\mathbb{P}_{ heta}(heta'\in C^*(oldsymbol{X})) \ \leq \ \mathbb{P}_{ heta}(heta'\in C(oldsymbol{X}))$$

that is, $C^*(\mathbf{X})$ is a UMA lower confidence bound.

• proof: let $\theta' < \theta$. Then

$$\begin{array}{rcl} \mathbb{P}_{\theta}\left(\theta'\in C^{*}(\boldsymbol{X})\right) &=& \mathbb{P}_{\theta}\left(\boldsymbol{X}\in A^{*}(\theta')\right)\\ \leq & \mathbb{P}_{\theta}\left(\boldsymbol{X}\in A(\theta')\right) &=& \mathbb{P}_{\theta}\left(\theta'\in C(\boldsymbol{X})\right) \end{array}$$

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Reference:

• Casella and Berger, Ch. 8 and 9

Exercises:

- 8.1-8.3, 8.5-8.8, 8.12-8.19, 8.22(a), 8.27, 8.28, 8.32, 8.37, 8.51
- 9.1-9.14, 9.16-9.17, 9.23, 9.34-9.42, 9.47-9.52

• proof: let [a', b'] be any interval with b' - a' < b - a. There are two cases: $b' \leq a$ and b' > a. If $b' \leq a$, then $a' \leq b' \leq a \leq x^*$ and

$$\int_{a'}^{b'} f(x) dx \leq f(b')(b'-a')$$

since $x \leq b' \leq x^* \Rightarrow f(x) \leq f(b')$. Now,

$$f(b')(b'-a') \leq f(a)(b'-a')$$

since f(x) is nondecreasing for $b' \leq a \leq x^*$ and

$$f(a)(b'-a') < f(a)(b-a) \leq \int_a^b f(x)dx = 1-\alpha$$

since, using (ii) and (iii), $f(x) \ge f(a)$ for $a \le x \le b$. So [a', b'] cannot have the same coverage probability. Complete argument for $b' \le a$ case.